

PATENT APPLICATION

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October 11, 2006

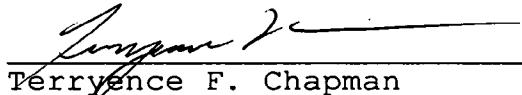
Applicants : Toshihiro TAI et al
For : PLATED RESIN MOLDED ARTICLES
PCT International Application No.: PCT/JP2005/002827
PCT International Filing Date: February 16, 2005
U.S. Application No.
(if known, see 37 CFR 1.5): 10/586 378
Atty. Docket No.: 3400.P1434US
Mail Stop PCT
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the provisions of Rules 1.97(b)(1) and 1.98, enclosed herewith is a copy of the International Search Report, Form PTO-1449 and the references cited thereon. The relevance of these references is explained on the enclosed search report. The remaining references are mentioned in Applicants' specification. Further comment at this point in time should not be necessary.

Respectfully submitted,


Terryence F. Chapman

TFC/smd

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Encl: International Search Report
Form PTO-1449 and one copy of each reference listed
thereon

336.05/03

INFORMATION DISCLOSURE CITATION	Applicant: Toshihiro TAI et al Ser.No.: 10/586 378 Conf. No.: 2951 Group: 1714	Filed: July 14, 2006 Atty. Docket No.: 3400.P1434US Date: October 11, 2006
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U.S. PATENT DOCUMENTS				
Examiner Initials*	Cite No.	Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant
	AA			
	AB			
	AC			
	AD			
	AE			
	AF			
	AG			
	AH			
	AI			
	AJ			
	AK			

FOREIGN PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Country Code - Document Number - Kind Code	Publication Date MM-DD-YYYY	Name of Patentee or Applicant	Trans.
/K.K./	AL	JP 7-330934	12-19-1995	HOYA et al	Abstract
/K.K./	AM	JP 57-123048	07-31-1982		
/K.K./	AN	JP 59-142244	08-15-1984	OKITA et al	Abstract
/K.K./	AO	JP 2004-2996	01-08-2004	TAI et al	Abstract
/K.K./	AP	JP 2003-82138	03-19-2003	TAI et al	Abstract
/K.K./	AQ	JP 2003-166067	06-13-2003	SOTOZAKI et al	Abstract

NON-PATENT LITERATURE DOCUMENTS (Include Author, Title, Date, Pages, Etc.)		
Examiner Initials*	Cite No.	
	AQ	
	AR	

EXAMINER SIGNATURE	/Kevin Kruer/	DATE CONSIDERED	09/29/2009
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.